Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/785,182	WANG ET AL.	
Examiner	Art Unit	

Anabel M. Ton

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	SEARCHED				
Class	Subclass	Date	Examiner		
362	218	9/12/2006	AT		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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